

Application/Control No.	Applicant(s)/Patent under Reexamination
10/715,031	E. ZAISER ET AL.
Examiner	Art Unit
Teena Mitchell	3771

	SEARCHED					
Class	Subclass	Date	Examiner			
128	201.21 201.26 202.27 203.21					
	363.24					
	204,25					
	205.24					
137	505,25 505					
	505 505.28 567					
25	368					

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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